

Notice of References Cited

Application/Control No.

10/712,202

Applicant(s)/Patent Under
Reexamination
HUEBNER ET AL.

Examiner

DEVANIE DUFOR

Art Unit

3733

Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,668,191	05-1987	Plischka, Gerhard	433/174
*	B	US-4,932,868	06-1990	Linkow et al.	433/174
*	C	US-5,275,601	01-1994	Gogolewski et al.	606/291
*	D	US-5,360,448	11-1994	Thramann, Jeffrey J.	606/60
*	E	US-5,735,898	04-1998	Br.ang.nemark, Per-Ingvar	623/11.11
*	F	US-5,925,048	07-1999	Ahmad et al.	606/308
*	G	US-6,059,785	05-2000	Schavan et al.	606/286
*	H	US-6,235,033 B1	05-2001	Brace et al.	606/288
*	I	US-6,302,883 B1	10-2001	Bono, Frank S.	606/291
*	J	US-6,477,923 B2	11-2002	Amis, James Peter	81/121.1
*	K	US-2003/0028193 A1	02-2003	Weil et al.	606/73
*	L	US-2003/0045881 A1	03-2003	Barouk et al.	606/73
*	M	US-6,599,290 B2	07-2003	Bailey et al.	606/86B

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	FR 2784020 A1	04-2000	France	ALLARD, MICHEL	A61F 02/08
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/712,202		Applicant(s)/Patent Under Reexamination HUEBNER ET AL.	
	Examiner DEVANIE DUFOUR		Art Unit 3733	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0181912 A1	09-2003	Michelson, Gary K.	606/61
*	B	US-2003/0229354 A1	12-2003	Schmieding et al.	606/99
*	C	US-2004/0230195 A1	11-2004	Kaikkonen et al.	606/072
*	D	US-2005/0038438 A1	02-2005	Anderson et al.	606/073
*	E	US-2005/0273105 A1	12-2005	Konieczynski et al.	606/069
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.